

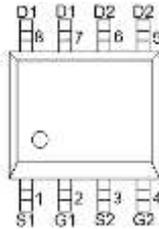
-30V_{DS}/±20V_{GS} P-Channel Enhancement Mode MOSFET

Features

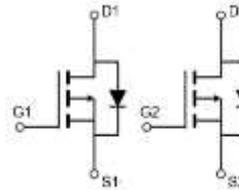
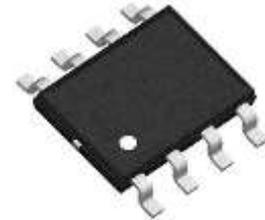
- V_{DS}=-30V, I_D=-5A
- R_{DS(ON)}=48mΩ (TYP.) V_{GS}=-10V
- R_{DS(ON)}=80mΩ (TYP.) V_{GS}=-4.5V
- Reliable and Rugged
- Avalanche Rated
- Low On-Resistance

Applications

- Load Switch
- Power management in portable/desktop PCs
- DC/DC conversion



SOP8



Ordering Information

Device	package	Device Marking	Package Qty.
HM4953A	SOP-8	HM4953A	3000/PCS

Absolute Maximum Ratings (T_C=25°C, unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage (V _{GS} =0V)	V _{DS}	-30	V
Gate-Source Voltage (V _{GS} =0V, static)	V _{GS}	±20	V
Continuous Drain Current (T _C =25°C)	I _D	-5	A
Continuous Drain Current (T _C =100°C)		-3.2	A
Pulsed Drain Current	I _{DM}	-20	A
Single Pulsed Avalanche Energy	E _{AS}	19	mJ
Maximum Power Dissipation (T _C =25°C)	P _D	2.0	W
Operating, Storage Temperature Range	T _J , T _{STG}	-55~150	°C

Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance, Junction-to-Case	R _{θJC}	-	23	-	°C/W
Thermal Resistance, Junction-to-Ambient	R _{θJA}	-	81	-	°C/W

Electrical Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250μA	-30	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-30V, V _{GS} =0V	-	-	-1	μA
Gate -Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D =-250μA	-0.6	-0.9	-1.2	V
Drain-Source On-stage Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-1A	-	13	20	mΩ
		V _{GS} =-4.5V, I _D =-1A	-	20	35	
Body Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _{SD} =-1A	-	-0.7	-1	V

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$V_{DS}=-15V$	-	650	-	pF
Output capacitance	C_{oss}	$V_{GS}=0V$	-	100	-	
Reverse transfer capacitance	C_{rss}	$f=1MHz$	-	65	-	
Gate Resistance	R_g	$f=1MHz$	-	3.3	-	Ω
Total Gate Charge	Q_g	$V_{DS}=-15V$	-	33	-	nC
Gate Source Charge	Q_{gs}	$V_{GS}=-10V$	-	4.8	-	
Gate Drain Charge	Q_{gd}	$I_D=-8A$	-	11	-	
Turn-on delay Time	$t_{d(on)}$	$V_{GS}=-10V$	-	5.5	-	ns
Rise time	t_r	$V_{DS}=-15V$	-	19	-	
Turn-off delay Time	$t_{d(off)}$	$R_L=1.7\Omega$	-	7	-	
Fall time	t_f	$R_G=3\Omega$	-	11	-	
Reverse Recovery Time	t_{rr}	$V_{GS}=0V, I_{SD}=-8A$	-	33	-	ns
Reverse Recovery Charge	Q_{rr}	$dI/dt=100A/\mu s$	-	25	-	nC

Electrical Characteristics Diagrames

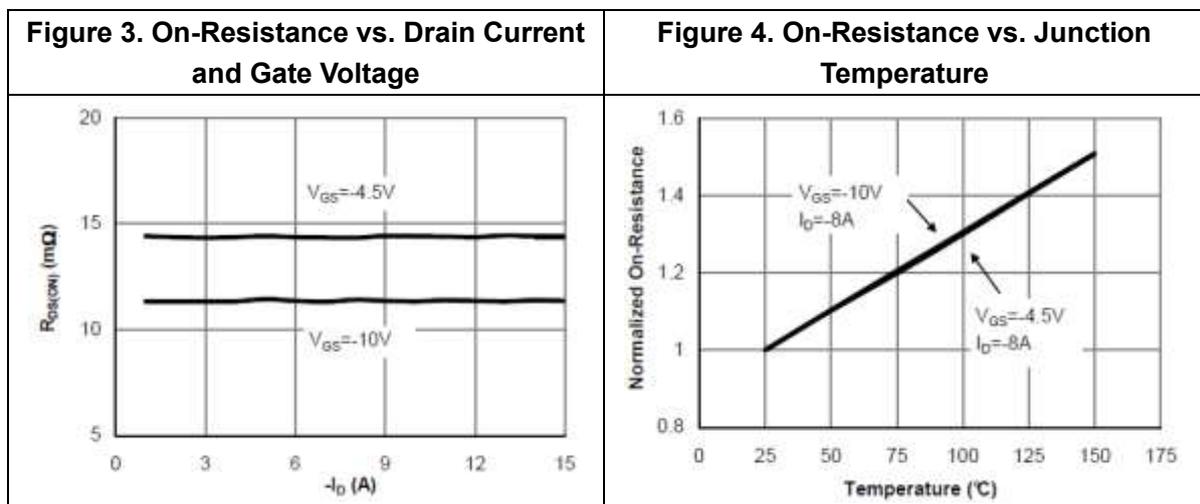
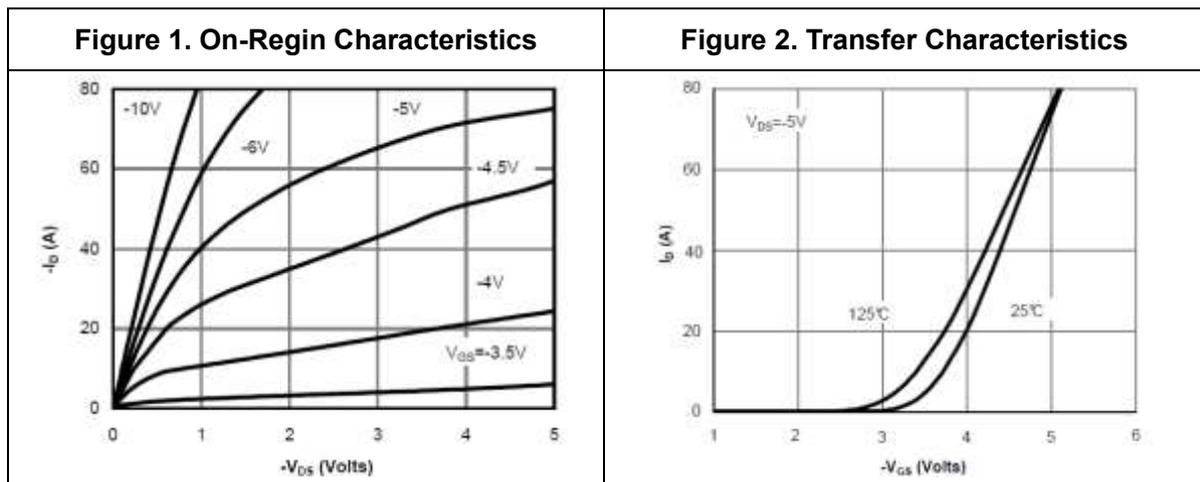


Figure 5. On-Resistance vs. Gate-Source Voltage

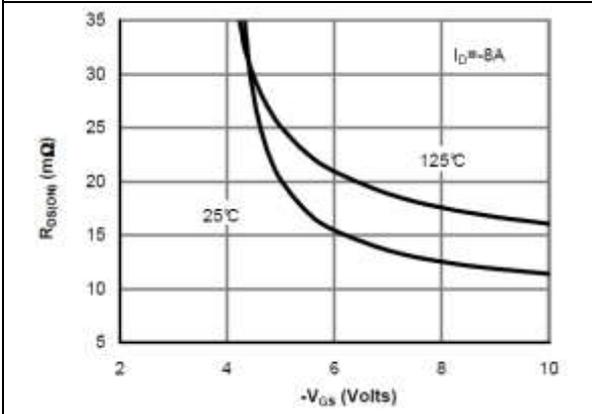


Figure 6. Body-Diode Characteristics

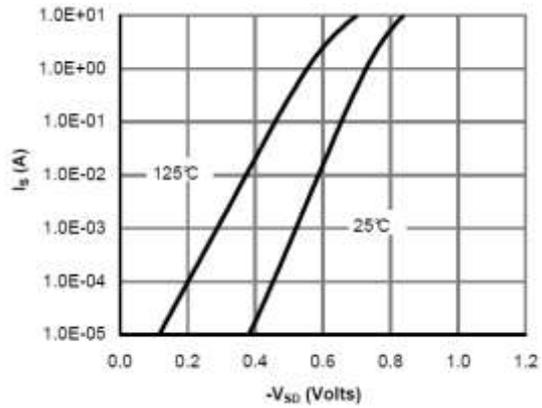


Figure 7. Gate-Charge Characteristics

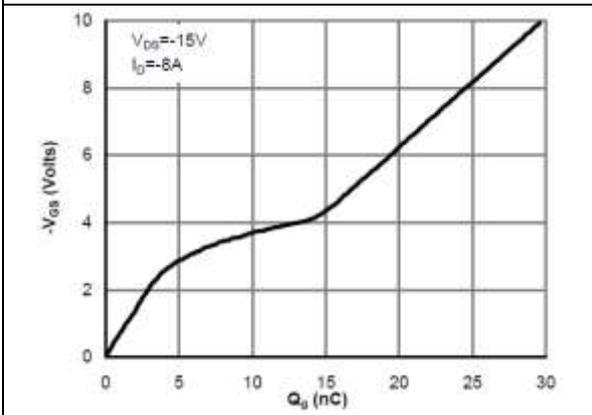


Figure 8. Capacitance Characteristics

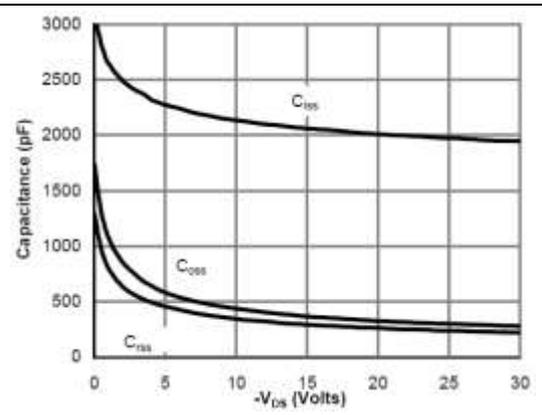


Figure 9. Maximum Forward Biased Safe Operating Area

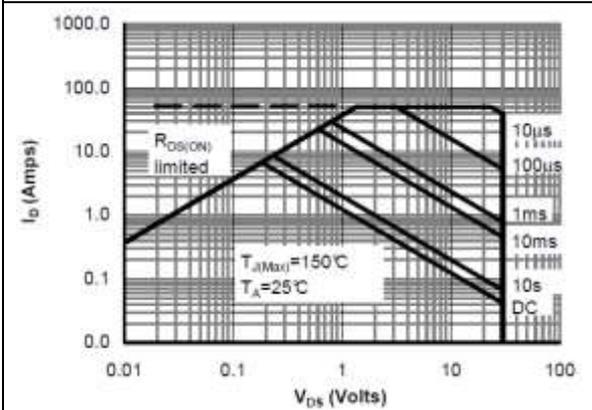


Figure 10. Single Pulse Power Rating Junction-to-Ambient

